

Form PTO-1449 U.S. Department of Commerce  
(Rev. 2-32) Patent and Trademark

**INFORMATION DISCLOSURE STATEMENT  
STATEMENT BY APPLICANT**  
(Use several sheets if necessary)

ATTY. DOCKET NO.  
BUN 8601

SERIAL NO.  
10/005881

APPLICANT  
Vandermeer, J.

FILING DATE  
November 8, 2001

GROUP 1725  
To Be assigned

U.S. PATENT DOCUMENTS

EXAMINER INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	2,806,270	<u>9-1957</u>	Shaul			
	AB	2,829,060	<u>4-1958</u>	Emblem			
	AC	3,396,775	<u>8-1968</u>	Scott			
	AD	3,455,368	<u>7-1969</u>	Shepherd			
	AE	3,748,157	<u>7-1973</u>	Moore			
	AF	3,751,276	<u>8-1973</u>	Beyer			
	AG	3,878,034	<u>4-1975</u>	Bever <i>et al</i>			
	AH	4352390	<u>10-1982</u>	Larson			
	AI	6000457	<u>12-1999</u>	Vandermeer			
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

EXAMINER INITIALS		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AL	2350810	4-25-2001	Britain				
	AM	207864	1991	EPO				
	AN							
	AO							
	AP							

EXAMINER INITIALS		OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)
	AQ	Rusher, Cast Metals Research Journal, Vol. 10, no. 4, 1974, pp. 149-153
	AR	Rusher, Cast Metals Research Journal, Vol. 11, no 4, 1954, pp. 21-26
	AS	

EXAMINER	<u>K. Y. Lin</u>	DATE CONSIDERED	<u>9/23/03</u>
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			

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<b>Form PTO-1449 U.S. Department of Commerce</b> <b>(Rev. 2-32) Patent and Trademark Office</b>  <b>INFORMATION DISCLOSURE STATEMENT</b> <b>STATEMENT BY APPLICANT</b> <i>(Use several sheets if necessary)</i>	<b>ATTY. DOCKET NO.</b> 8601	<b>SERIAL NO.</b> 10 005 881
	<b>APPLICANT</b> Vandermeer, J	
	<b>FILING DATE</b> November 8, 2001	<b>GROUP</b> To be assigned 1725

## U.S. PATENT DOCUMENTS

EXAMINER INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	6450243	9-17-02	Shaw et al.			10-3-2000
	AB	4531705	1986-7-1988	Nakagawa et al			
	AC	5198006	3-1993	Mimori et al			
	AD						
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